CHANGE NOTIFICATION



July 30, 2014

Dear Sir/Madam: PCN# 073014

Subject: Notification of Additional Assembly Location, ASE Korea for LTM4616

Please be advised that Linear Technology Corporation has successfully qualified ASE Korea as an assembly site for the subject packages. It was desirable to qualify ASE Korea to serve as an alternate source since it is located in a different geographic area than our existing assembly location in Penang, Malaysia. ASE Korea is ISO9002, QS9000, ISO14001, TS16949, OHSAS 18001 and QC80000 certified. A summary of ASE Korea's product mix and LTC's qualification results are shown on the attached pages. The facility passed a site audit by LTC's supplier quality organization. LTC product assembled in ASE Korea can be identified by the country of origin marked on the device as "KR". The product photo showing the ASE Korea marking is attached. The Approximate datecode of the first units assembled by ASE Korea, and the list of affected part numbers is presented below in the table.

Part Number	Part Marking	Package Type	Datecode (Approx.)	
LTM4616EV#PBF	LTM4616V	LGA	1414	
LTM4616IV#PBF	LTM4616V	LGA		

In addition, a minor change to the internal package construction was made on this device in order to facilitate the use of one attach material for both die and components. The die attach material is changed from epoxy to solder, which is already used for attaching components in the same µModule device package. In order to use the solder die attach, the die attach paddle (DAP) has been modified by splitting the DAP into multiple pads for dice U1 and U2. Linear has been shipping several µModule devices using solder for die attach and component attach.

Parts incorporating the new substrate design have been fully characterized and tested for package level reliability. The change was qualified by performing extensive characterization over the full operating voltage and temperature ranges and MSL3 preconditioning. Devices from the same µModule device product family have been subjected to 1000 cycles of temperature cycles and thermal shock. Linear Technology performs reliability testing on production lots in accordance with our Quick Reaction Reliability (QR2) Monitor Program. This monitor program is designed to provide fast feedback for possible reliability problems associated with package assembly. Please provide an expeditious approval to this PCN, so that LTC can build subject packages at ASE.

Should you have any concerns, please contact me before September 30, 2014, at which time we w	ʻill
consider this change to be approved. If you have any questions or concerns, please feel free to	
contact me at (408) 432-1900 ext. 2077 or by e-mail at <u>JASON.HU@LINEAR.COM.</u>	

Sincerely,

Jason Hu Quality Assurance Engineer

ASE Korea Capacity Summary

ASE Korea 76, Saneopdanji-gil, Paju-si, Gyeonggi-do, Korea

Tel: 82-31-9400-114, 82-31-9400-539

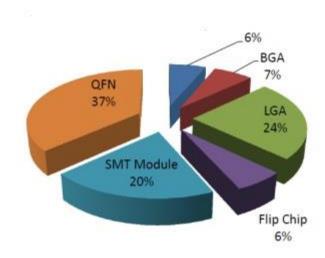
Head counts: 2,791

Package Portfolio - Breakdown ** ASE GROUP



- Analog Power for Automotive
- RF for digital/consumer
- MEMS for safety
- Array Packages

2013 Production Mix by Package

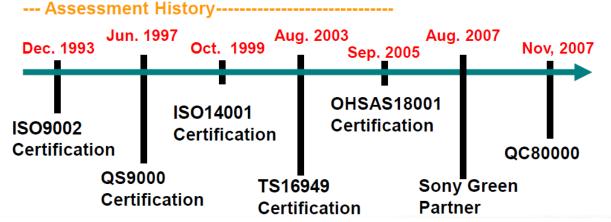


Quality System Certification



- ISO9002 certified by SGS-Yarsely in December 1993.
- QS9000 certified by LRQA in June 1997
- ISO14001 certified by LRQA in October 1999
- TS16949 certified by LRQA in August 2003
- OHSAS18001 certified by KFQ in September 2005
- Sony Green Partner certified by Sony in August 2007
- QC80000 certified by SGS in November 2007

*Surveillance Audit: Every 6 Months

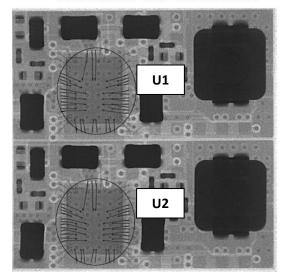


Country of Origin on Top Mark



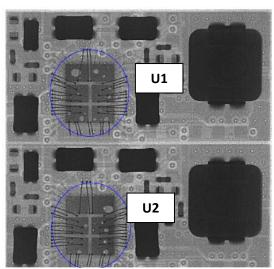
Before

LTM4616-EPOXY DIE ATTACH



After

LTM4616-SOLDER DIE ATTACH





PACKAGE RELIABILITY DATA LTM4616 / LTM4619 / LTM8023 / LTM8032 ASE ASSEMBLY SITE QUALIFICATION

7/8/2014

7/8/2014							
J-STD-020 MSL 3 PRECONDITIONING: 192h +30°C/60%R.H. SOAK, 3x REFLOW AT +245°C PEAK							
DEVICE TYPE	SAMPLE SIZE	OLDEST DATE CODE	NEWEST DATE CODE		NUMBER OF FAILURES		
LTM4616 LTM4619 LTM8023	231 231 385	1414 1411 1411	1414 1411 1411		0		
LTM8032	385 1,232	1411	1411		0		
• TEMP CYCLE FROM -55°C to +125°C (1)							
DEVICE TYPE	SAMPLE SIZE	OLDEST DATE CODE	NEWEST DATE CODE	K DEVICE CYCLES	NUMBER OF FAILURES		
LTM4616 LTM4619	77 77	1414 1411	1414 1411	38.50 38.50	0		
LTM8023	77	1411	1411	38.50	ŏ		
LTM8032	77 308	1411	1411	38.50 154.00	0		
• TEMP CYCLE FROM -65°C to +150°C (1)							
DEVICE TYPE	SAMPLE SIZE	OLDEST DATE CODE	NEWEST DATE CODE	K DEVICE CYCLES	NUMBER OF FAILURES		
LTM8023 LTM8032	77 77	1411 1411	1411 1411	38.50 77.00	0 0		
TUEDINA AUGO	154	enero (f)		115.50	0		
	K FROM -55°C to +1				NUMBER		
DEVICE TYPE	SAMPLE SIZE	DATE CODE	DATE CODE	CYCLES CYCLES	OF FAILURES		
LTM4616 LTM4619	74 77	1414 1411	1414 1411	37.00 77.00	0		
LTM8023	77	1411	1411	77.00	ő		
LTM8032	77	1411	1411	38.50	ō		
TUEDIA 1 01100	305	reas (f)		229.50	0		
• THERMAL SHOCK FROM -65°C to +150°C (1)							
DEVICE TYPE	SAMPLE SIZE	DATE CODE	DATE CODE	K DEVICE CYCLES	OF FAILURES		
LTM8023	77	1411	1411	77.00	0		
LTM8032	77 154	1411	1411	77.00 154.00	0 0		
HIGH TEMPERAT	URE STORAGE +1	50°C					
DEVICE TYPE	SAMPLE SIZE	OLDEST DATE CODE	NEWEST DATE CODE	K DEVICE HOURS AT +150°C	NUMBER OF FAILURES		
LTM4616	77	1414	1414	38.50	0		
LTM4619 LTM8023	77 77	1411 1411	1411 1411	77.00 77.00	0		
LTM8032	77	1411	1411	77.00	0		
· UNBIASED HIGH	308 LY ACCELERATED	STRESS TEST +13	0°C/85% R.H. (1)	269.50	0		
DEVICE TYPE	SAMPLE SIZE	OLDEST DATE CODE	NEWEST DATE CODE	K DEVICE HOURS AT +130°C	NUMBER OF FAILURES		
LTM4616	77 77	1411	1411	3.70 3.70	0		
 UNBIASED TEMP 	ERATURE/HUMIDI	TY STORAGE TEST	+85°C/85% R.H. (1)				
DEVICE TYPE	SAMPLE SIZE	OLDEST DATE CODE	NEWEST DATE CODE	K DEVICE HOURS AT +85°C	NUMBER OF FAILURES		
LTM8023 LTM8032	77 77 154	1411 1411	1411 1411	38.50 38.50 77.00	000		
 Environmental stress are preceded by J-STD-020 Level 3 Preconditioning: 192h 30°C/60% R.H. soak, followed by 3x Reflow at 245°C. 							